


RefMat No



Included in
COMAR Database:
Green 1 --> YES
Blue 0 --> NO

Category 1	Lateral (X-Y-axis, 1-dim)
Category 2	<input type="text"/>
Category 3	<input type="text"/>
Category 4	<input type="text"/>
Category 5	<input type="text"/>

Type_of_RefMat:

Name of RM: BAM L200 Nanoscale stripe pattern

Description: Nanoscale stripe pattern for testing of lateral resolution; 3.5, 14.2, 19.5, 38, 96, ..., 691, 986, 4642 nm and calibration of length scale

Link: http://www.webshop.bam.de/product_info.php?cPath=2282_2315&products_id=3225&PHPSESSID=158217445fb3ade6

Certified Quantities						
lateral distance	MeanValue	3,5	nm	Uncertainty	0,7	nm
lateral distance	MeanValue	3,6	nm	Uncertainty	0,8	nm
lateral distance	MeanValue	6,9	nm	Uncertainty	1	nm
lateral distance	MeanValue	9,4	nm	Uncertainty	1,4	nm
lateral distance	MeanValue	13,3	nm	Uncertainty	1,1	nm

Calibration of	AES
Calibration of	ESCA
Calibration of	SEM
Calibration of	SIMS
Calibration of	ToF-SIMS

Characterised by	<input type="text" value="TEM"/>
Characterised by	<input type="text"/>
Characterised by	<input type="text"/>
Characterised by	<input type="text"/>
Characterised by	<input type="text"/>

2 Provider

Provider No

Provider No	<input type="text" value="4"/>	Web address	<input type="text" value="http://www.webshop.bam.de/default.php?cPath=0&language=en"/>
Provider	BAM (Federal Institute for Materials Research & Testing)		
Contact Person	<input type="text"/>	Country	<input type="text" value="Germany"/>
Email	<input type="text" value="webshop@bam.de"/>	City	<input type="text" value="Berlin"/>
Phone	<input type="text"/>	City Code	<input type="text" value="D-12203"/>
		Street + No	<input type="text" value="Unter den Eichen 87"/>